

On some factors controlling fission-track etch rates in apatite

Raymond Jonckheere^{1*}, Florian Trilsch¹, Jie Liu², Pengfei Zhai², Thorsten Nagel¹

¹Geologie, Technische Universität Bergakademie Freiberg, Deutschland

²Institute of Modern Physics, Chinese Academy of Sciences, Lanzhou, Gansu 730000, China

Supplements

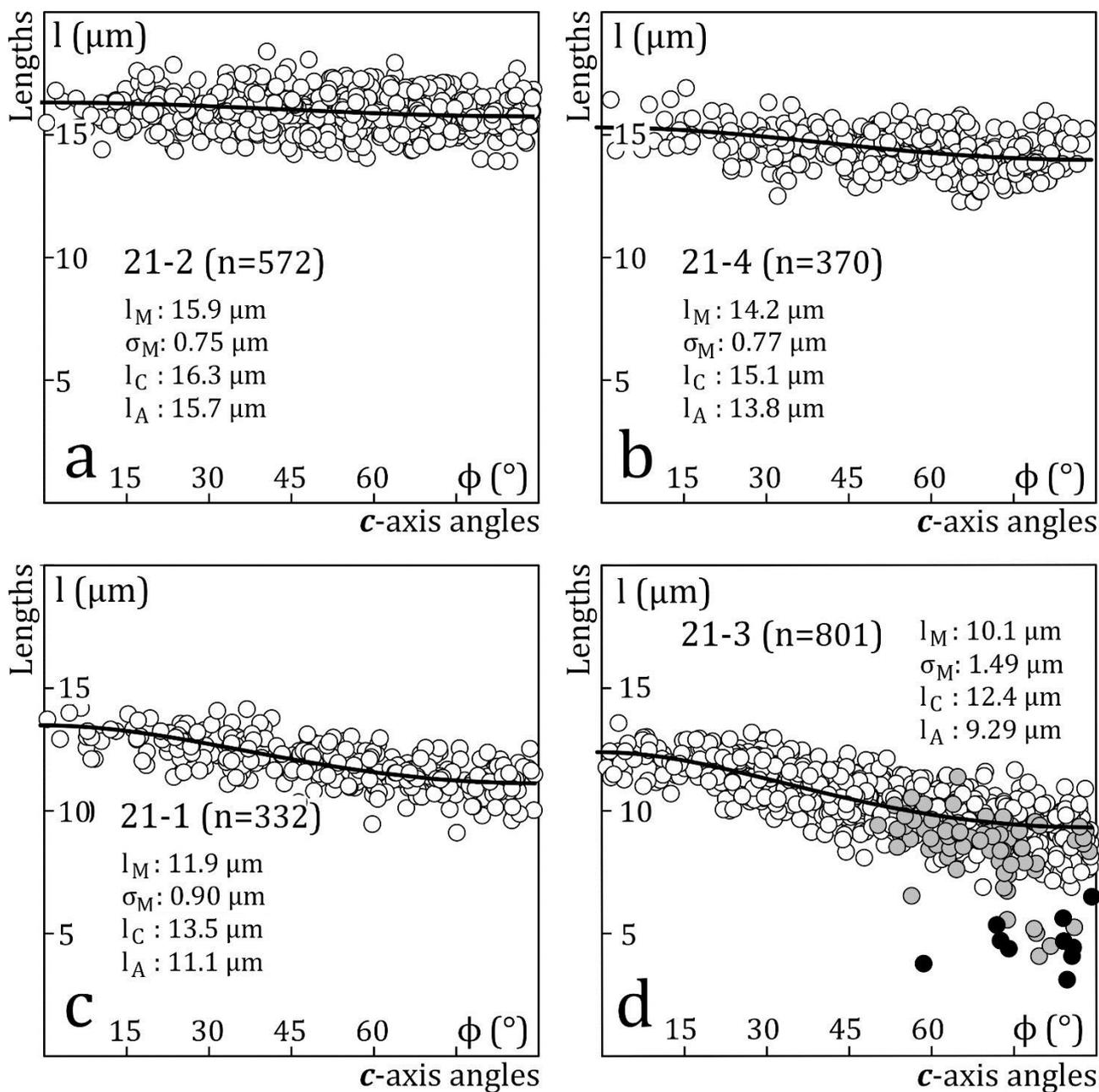


Figure S01. Measured lengths of induced horizontal confined tracks in the four investigated samples plotted against their c -axis angles: **(a)**: unannealed; **(b)**: annealed 10 h at 240°C ; **(c)**: 288°C ; **(d)** 310°C (Ketcham et al., 2015). White circles: continuous tracks; grey circles: stepped tracks; black circles: gapped tracks. The solid lines are ellipses fitted to the data; l_M : mean track length; σ_M : standard deviation of the track length distribution; l_C : c -axis intercept of ellipse; l_A : a -axis intercept.

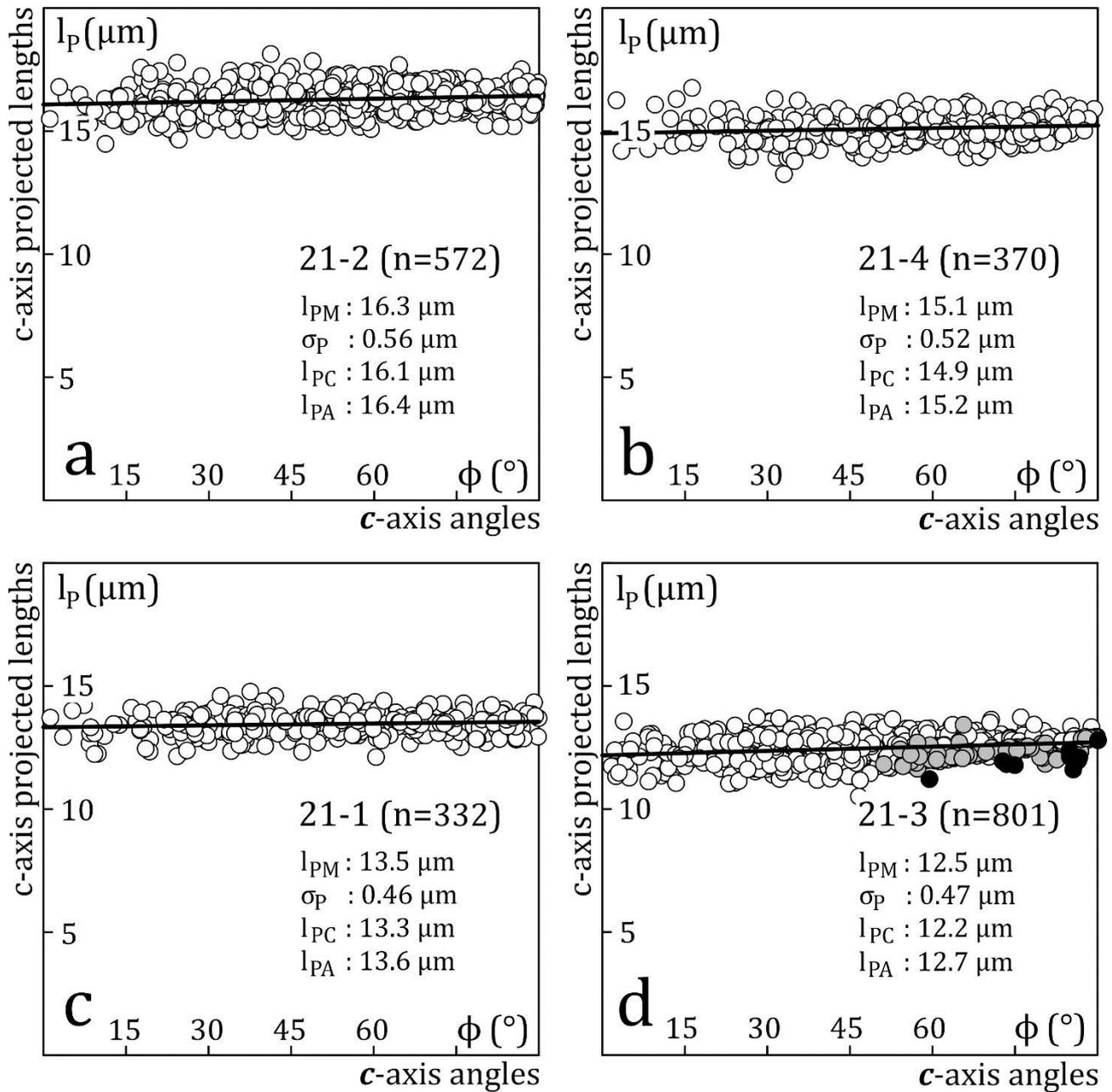


Figure S02. c -axis-projected lengths of induced horizontal confined tracks in the four investigated samples, plotted against their true c -axis angles: **(a)**: unannealed; **(b)**: annealed 10 h at 240 °C; **(c)**: 288 °C; **(d)**: annealed 10 h at 310 °C (Ketcham et al., 2015). White circles: continuous tracks; grey circles: stepped tracks; black circles: gapped tracks. The solid lines are linear regression lines; l_{PM} : mean c -axis-projected track length; σ_P : standard deviation of the c -axis-projected track lengths; l_{PC} : c -axis intercept of the fitted regression line; l_{PA} : a -axis intercept of the fitted regression line.

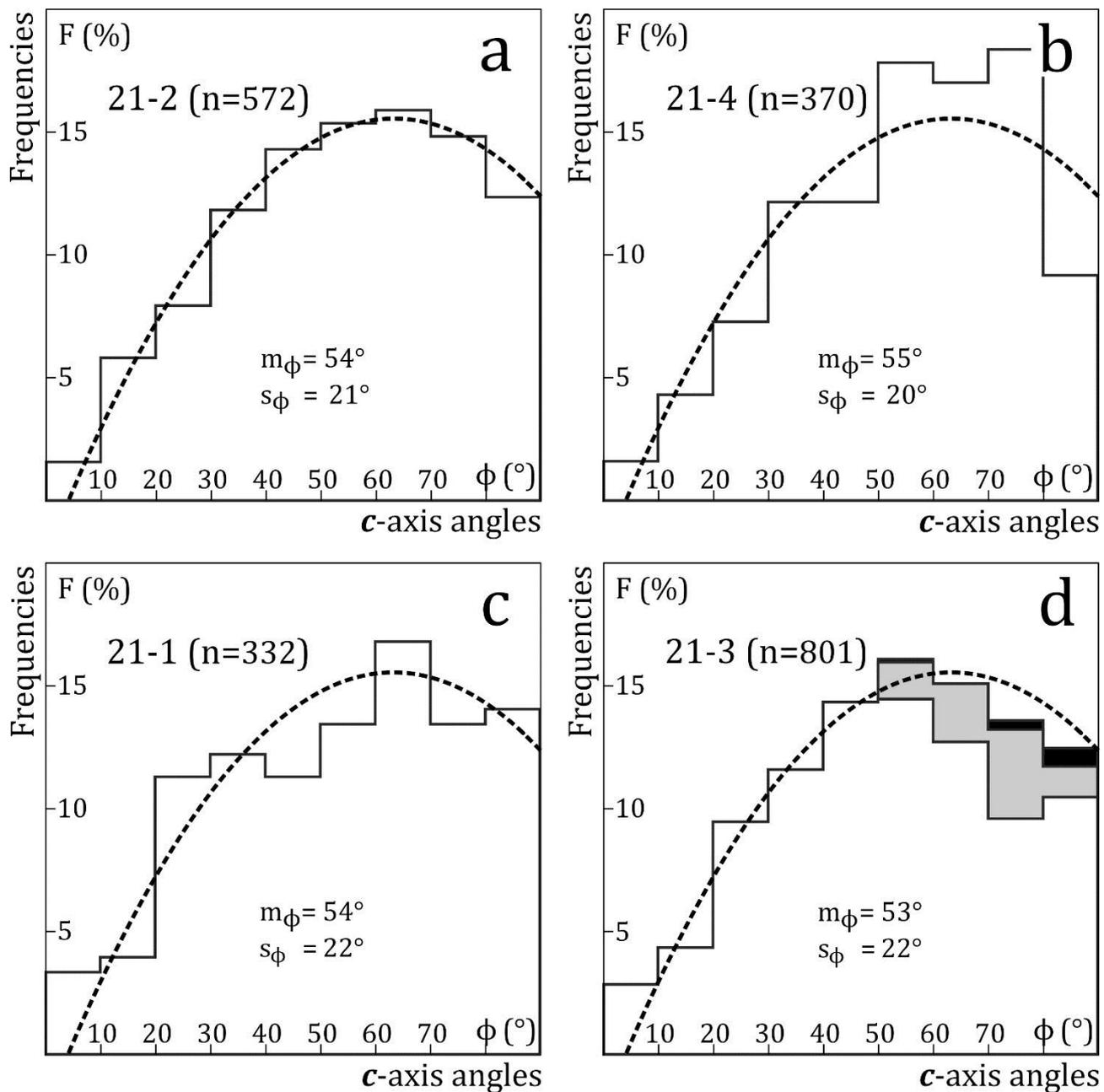


Figure S03. Distribution of the c -axis angles for the four investigated samples: (a): unannealed; (b): annealed 10 h at 240 °C; (c): 288 °C; (d): 310 °C (Ketcham et al., 2015). white: continuous tracks; grey: stepped tracks; black: gapped tracks; the dashed line is a polynomial fit to the combined data for the four samples (including high-angle tracks); m_ϕ : mean angle; s_ϕ : standard deviation.

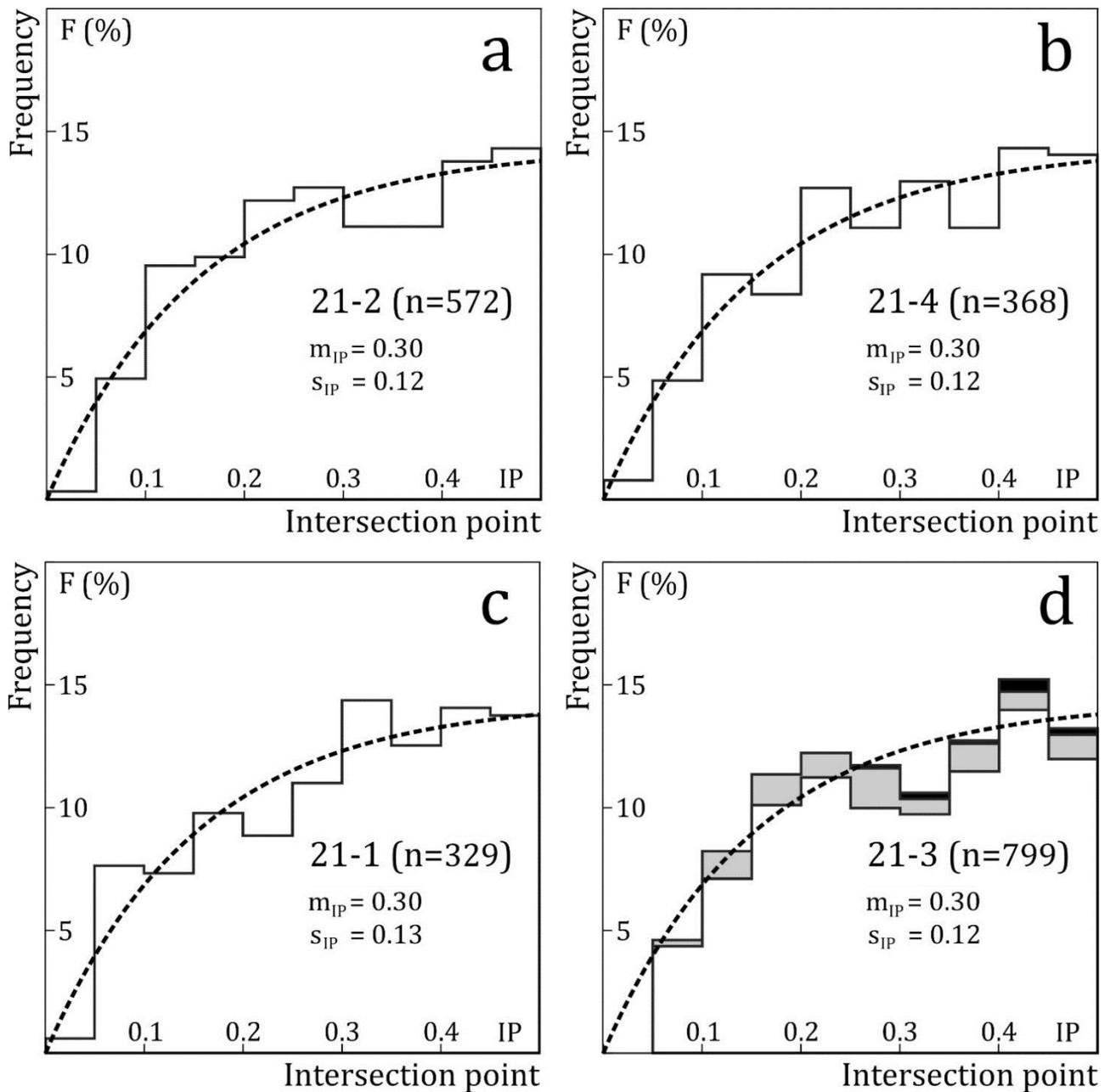


Figure S04. Distribution of the host-track intersections for the four investigated samples: (a): unannealed; (b): annealed 10 h at 240 °C; (c): 288 °C; (d): 310 °C (Ketcham et al., 2015). White: continuous tracks; grey: stepped tracks; black: gapped tracks; the dashed line is a polynomial fit to the combined data for the four samples (including high-angle tracks); m_{IP} : mean intersection; s_{IP} : standard deviation.

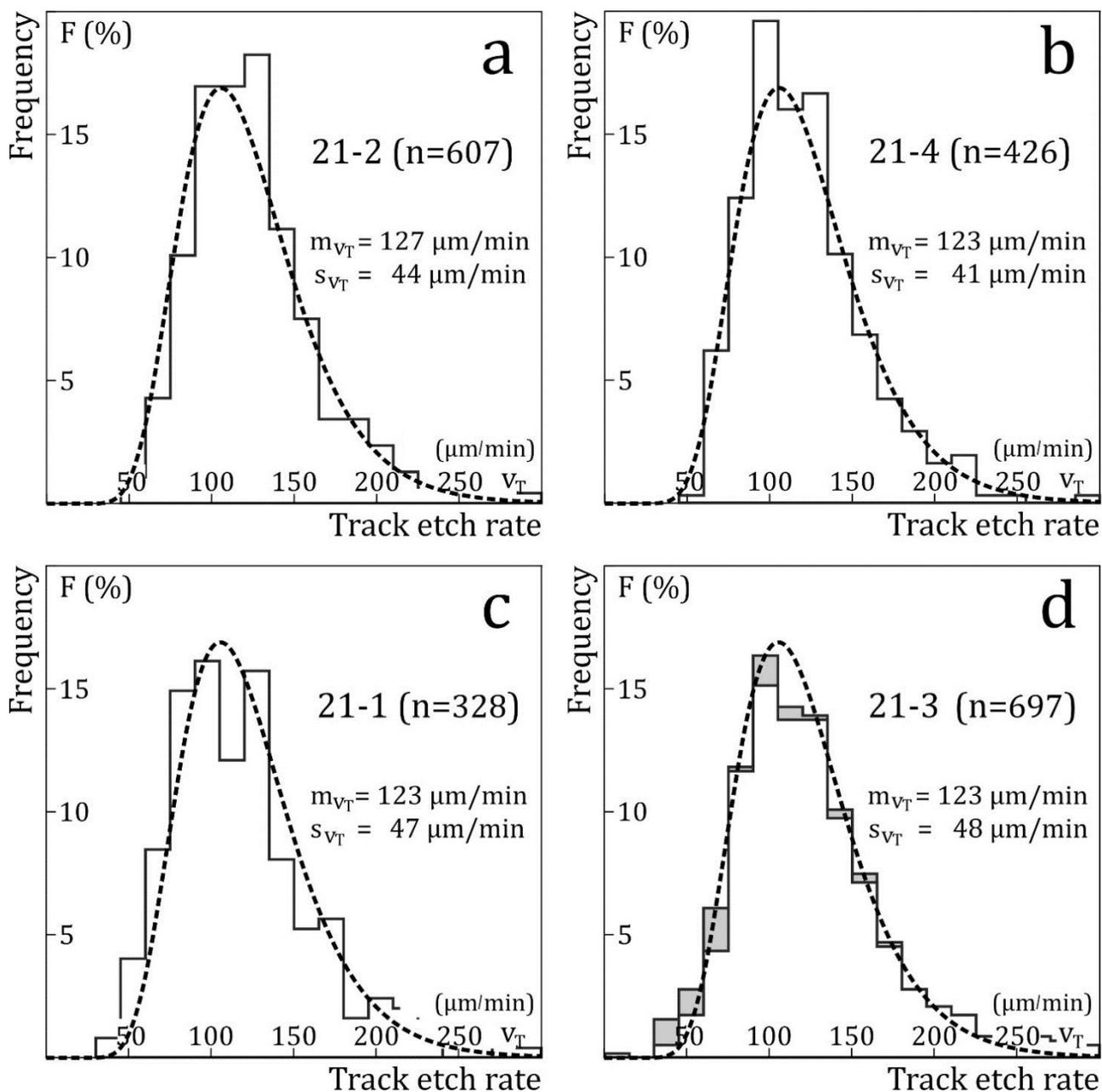


Figure S05. Distribution of the track etch rate for the four studied samples; **(a)**: unannealed; **(b)**: annealed 10 h at 240 °C; **(c)**: 288 °C; **(d)**: 310 °C (Ketcham et al., 2015). The dashed line is a polynomial fit to the combined data for the four samples; m_{v_T} and s_{v_T} : arithmetic mean and standard deviation.

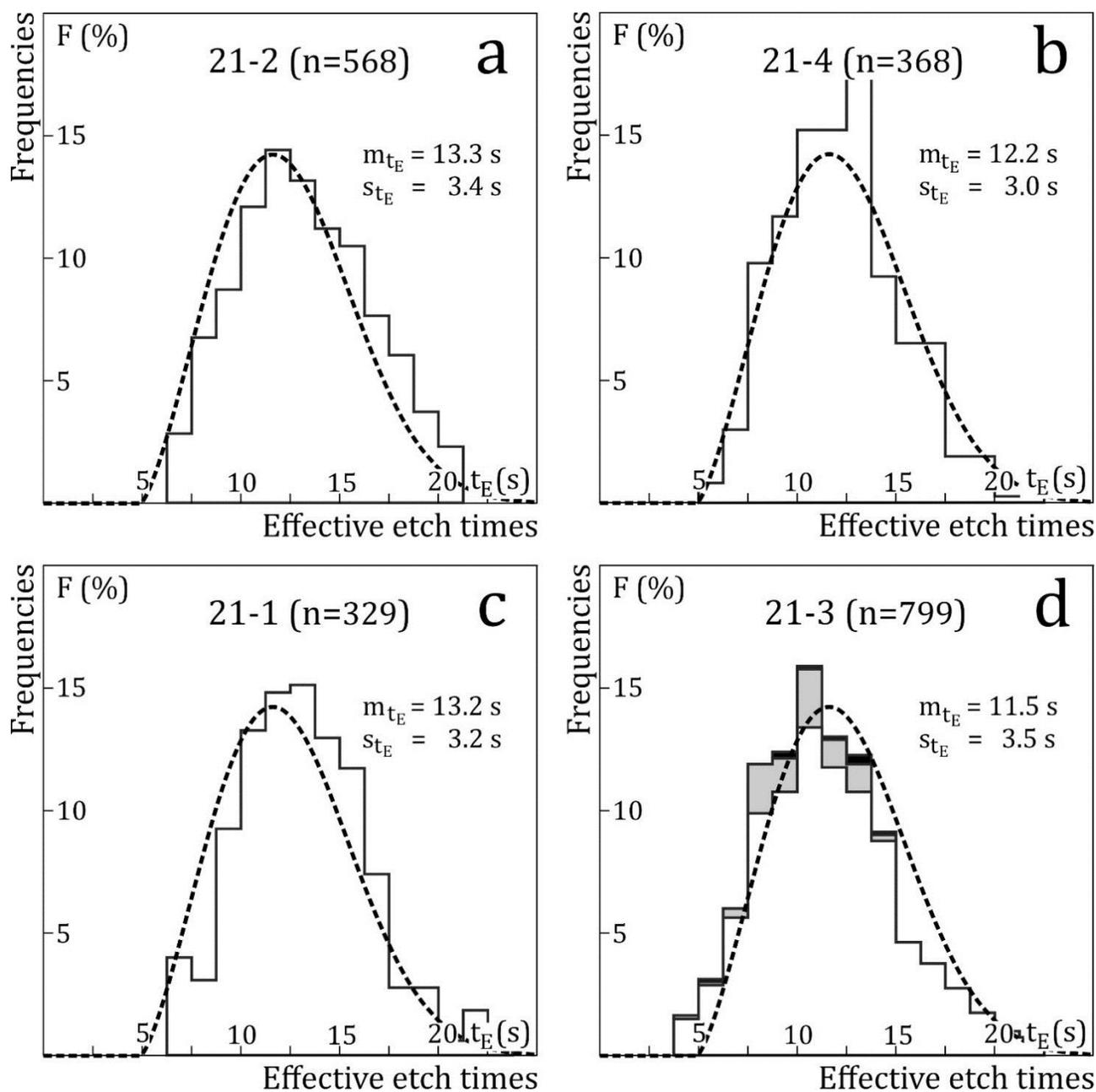


Figure S06. Effective etch time distributions for the four studied samples; (a): unannealed; (b): annealed 10 h at 240 °C; (c): 288 °C; (d): 310 °C (Ketcham et al., 2015). White: continuous tracks; grey: stepped tracks; black: gapped tracks; the short-dashed line is a polynomial fit to the combined data for the four samples; $t_{E,M}$ and s_{t_E} : arithmetic mean and standard deviation of the etch-time distribution.

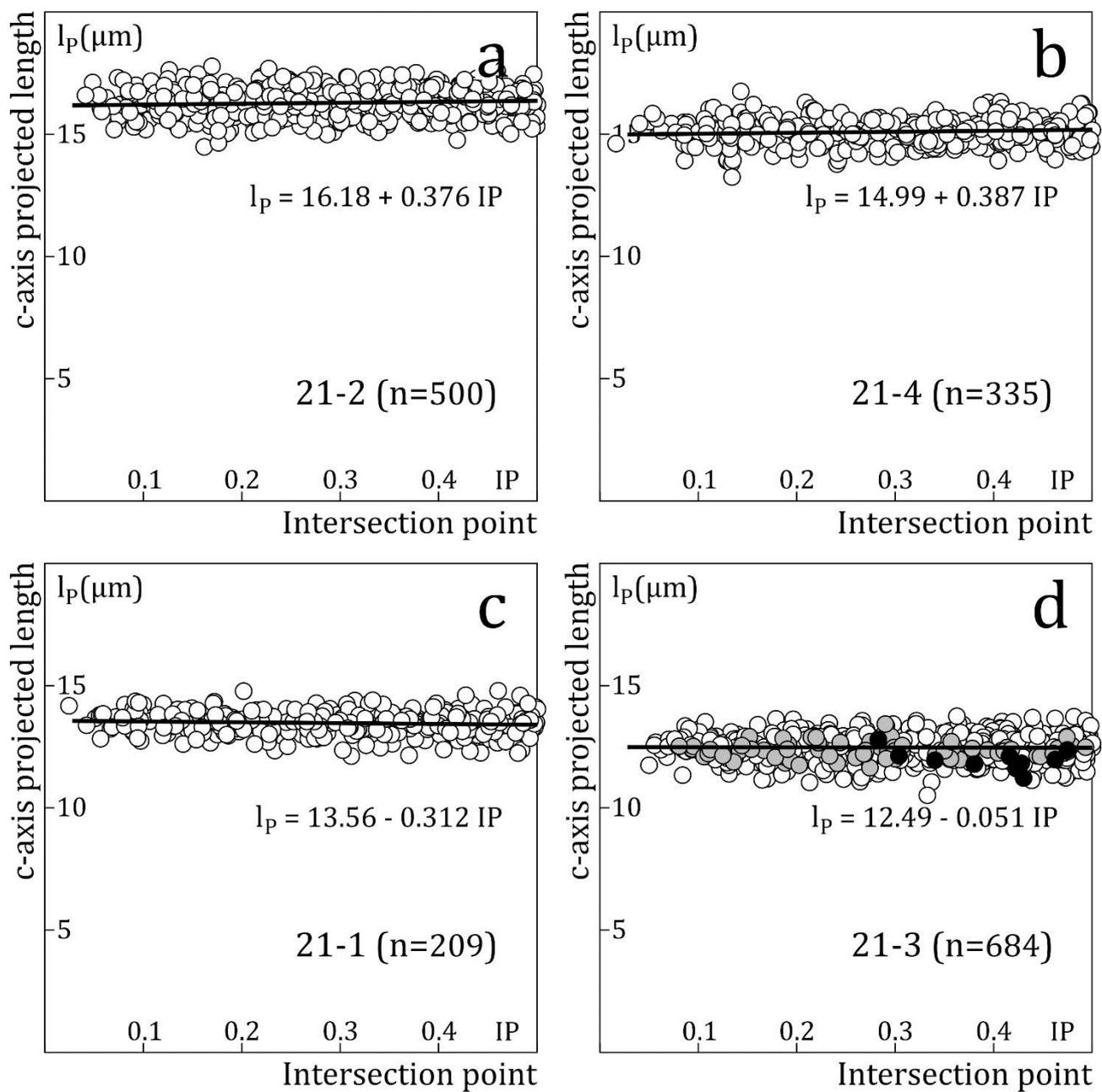


Figure S07. c-axis-projected lengths of confined tracks plotted against their host-track intersections; (a): unannealed sample; (b): annealed 10 h at 240 °C; (c): 288 °C; (d): 310 °C (Ketcham et al., 2015). White: continuous tracks; grey: stepped tracks; black: gapped tracks; the solid lines are regression lines.

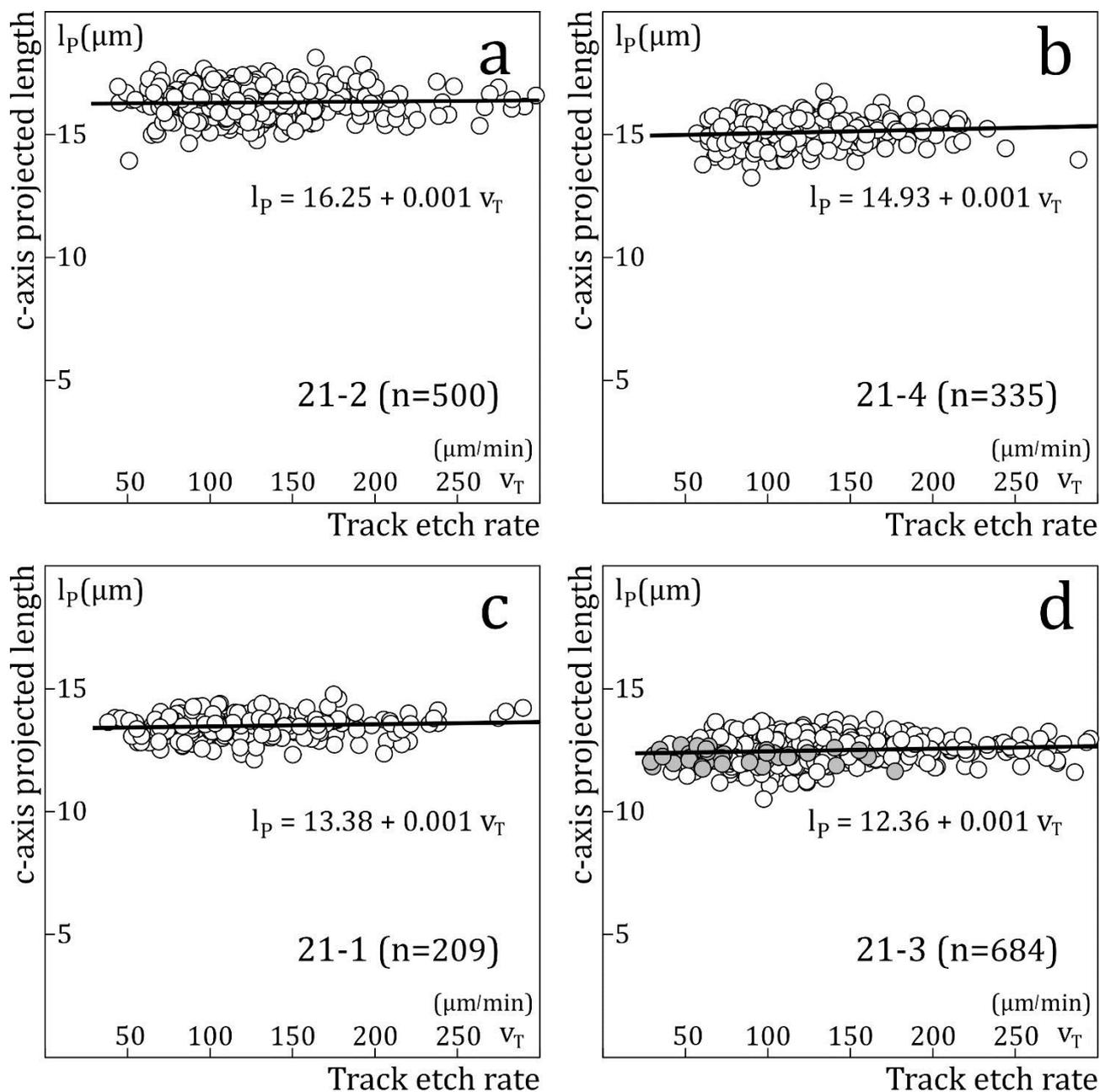


Figure S08. *c*-axis-projected lengths of horizontal induced confined tracks plotted against their track etch rates; **(a)**: unannealed sample; **(b)**: annealed 10 h at 240 °C; **(c)**: 288 °C; **(d)**: 310 °C (Ketcham et al., 2015). White: continuous tracks; grey: stepped tracks; the solid lines are regression lines.

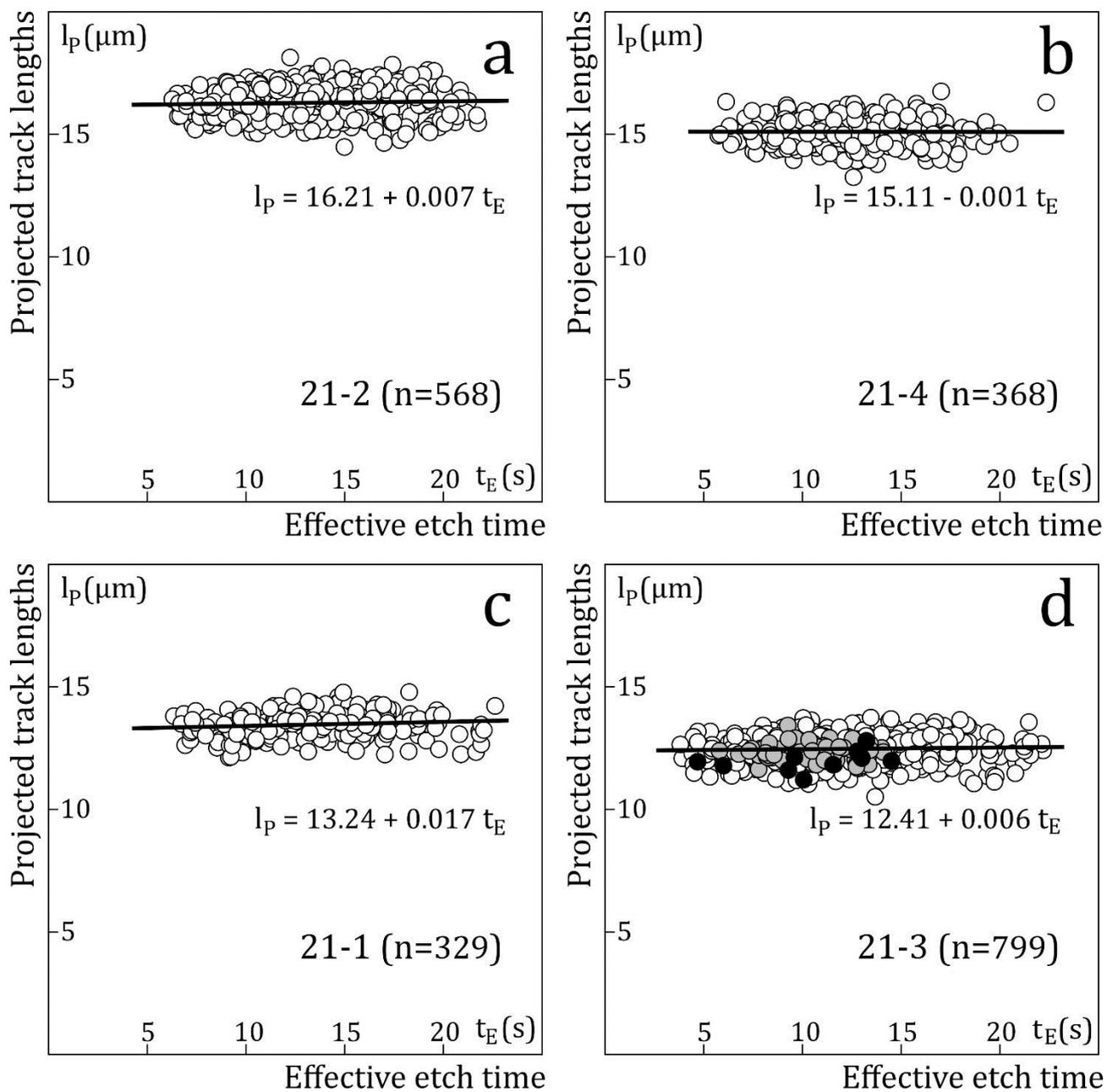


Figure S09. *c*-axis-projected lengths of induced confined tracks plotted against their effective etch times; **(a)**: unannealed sample; **(b)**: annealed 10 h at 240 °C; **(c)**: 288 °C; **(d)**: 310 °C (Ketcham et al., 2015). White: continuous tracks; grey: stepped tracks; black: gapped tracks; the solid lines are regression lines.

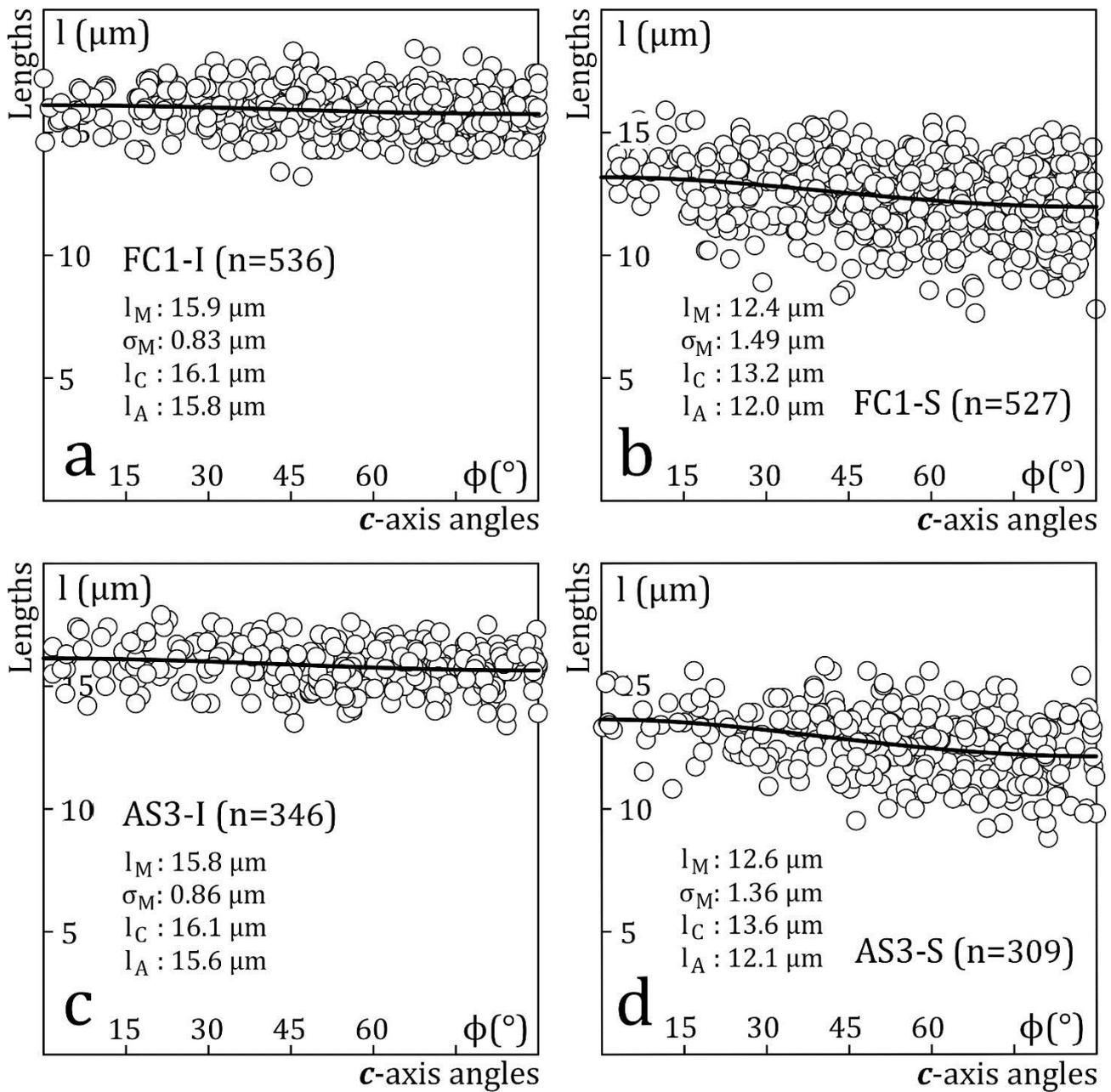


Figure S10. Measured lengths of induced and fossil confined tracks in samples from the Duluth complex; **(a)**: FC-1 induced; **(b)**: FC-1 fossil; **(c)**: AS-3 induced; **(d)** AS3 fossil. The solid lines are ellipses fitted to the data; l_M : mean track length; σ_M : standard deviation; l_C : c -axis intercept of ellipse; l_A : a -axis intercept.

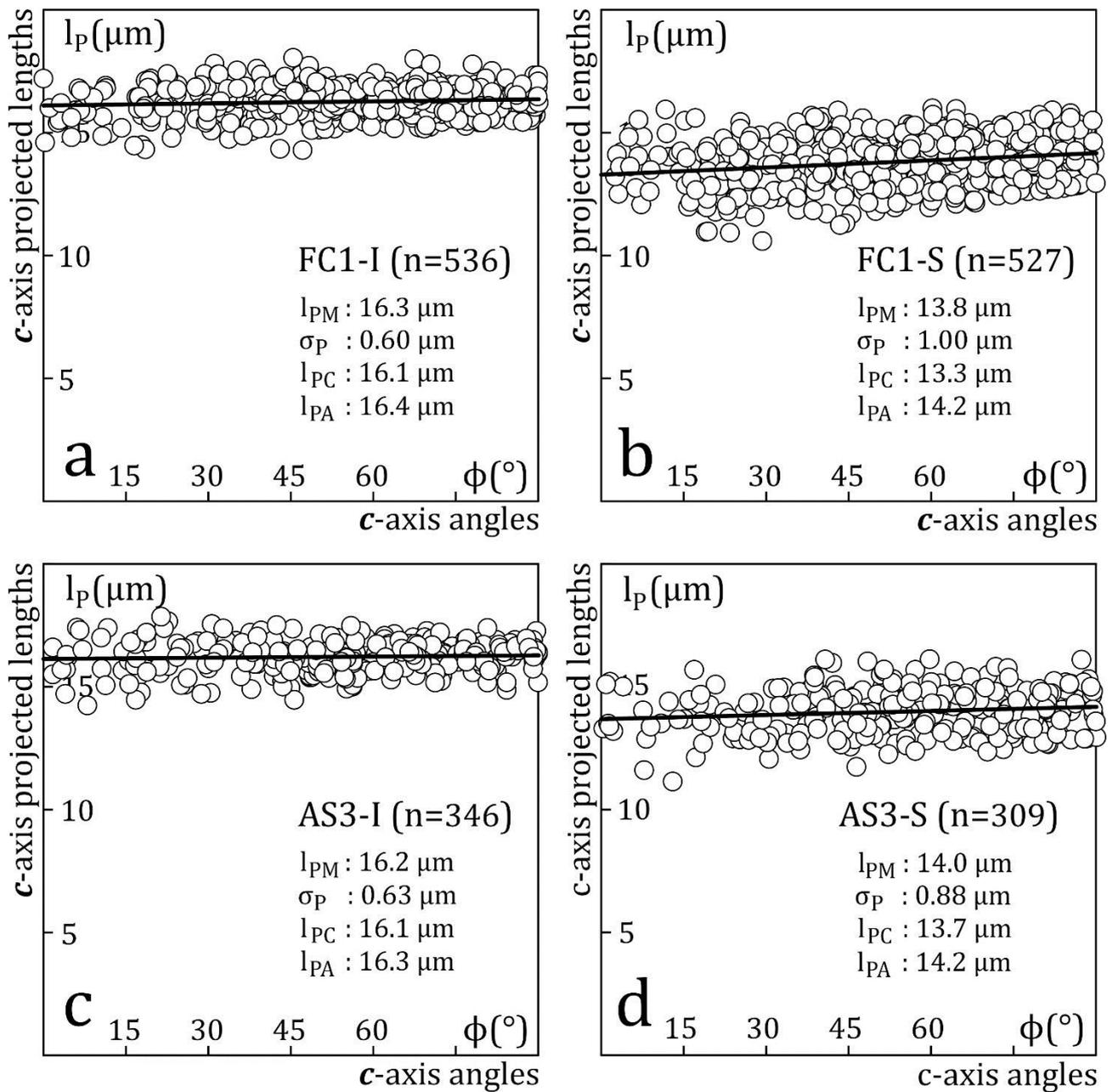


Figure S11. *c*-axis-projected lengths of induced and fossil confined tracks in samples from the Duluth complex; **(a)**: FC-1 induced; **(b)**: FC-1 fossil; **(c)**: AS-3 induced; **(d)** AS3 fossil. The solid lines are regression lines; l_{PM} : mean track length; σ_{PM} : standard deviation; l_{PC} : *c*-axis intercept of ellipse; l_{PA} : *a*-axis intercept.

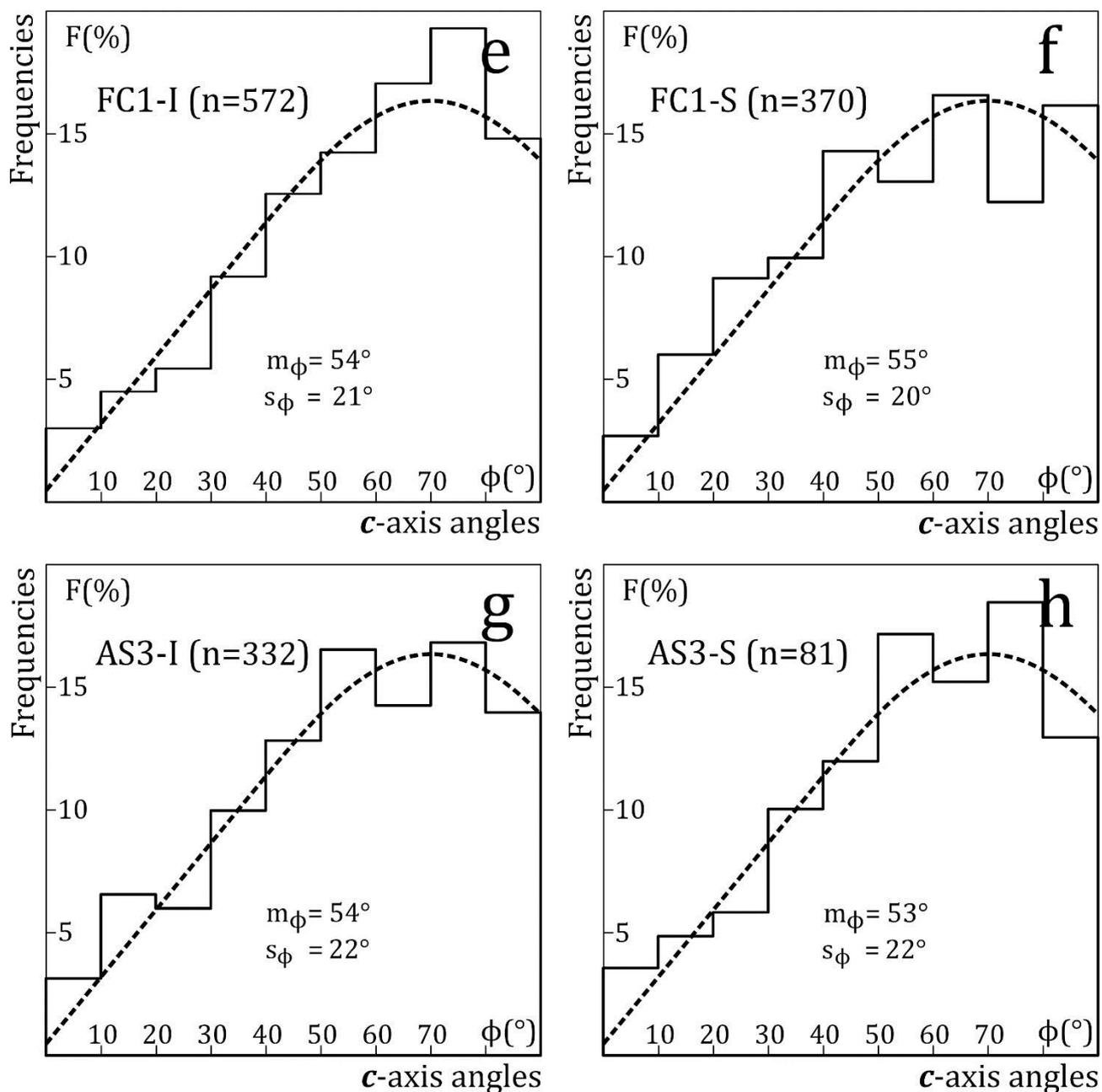


Figure S12. Distribution of the c -axis angles of induced and fossil confined tracks in samples from the Duluth complex; **(a)**: FC-1 induced; **(b)**: FC-1 fossil; **(c)**: AS-3 induced; **(d)** AS-3 fossil. The dashed line is a polynomial fit to the combined data for the four samples; m_{ϕ} : mean; s_{ϕ} : standard deviation.

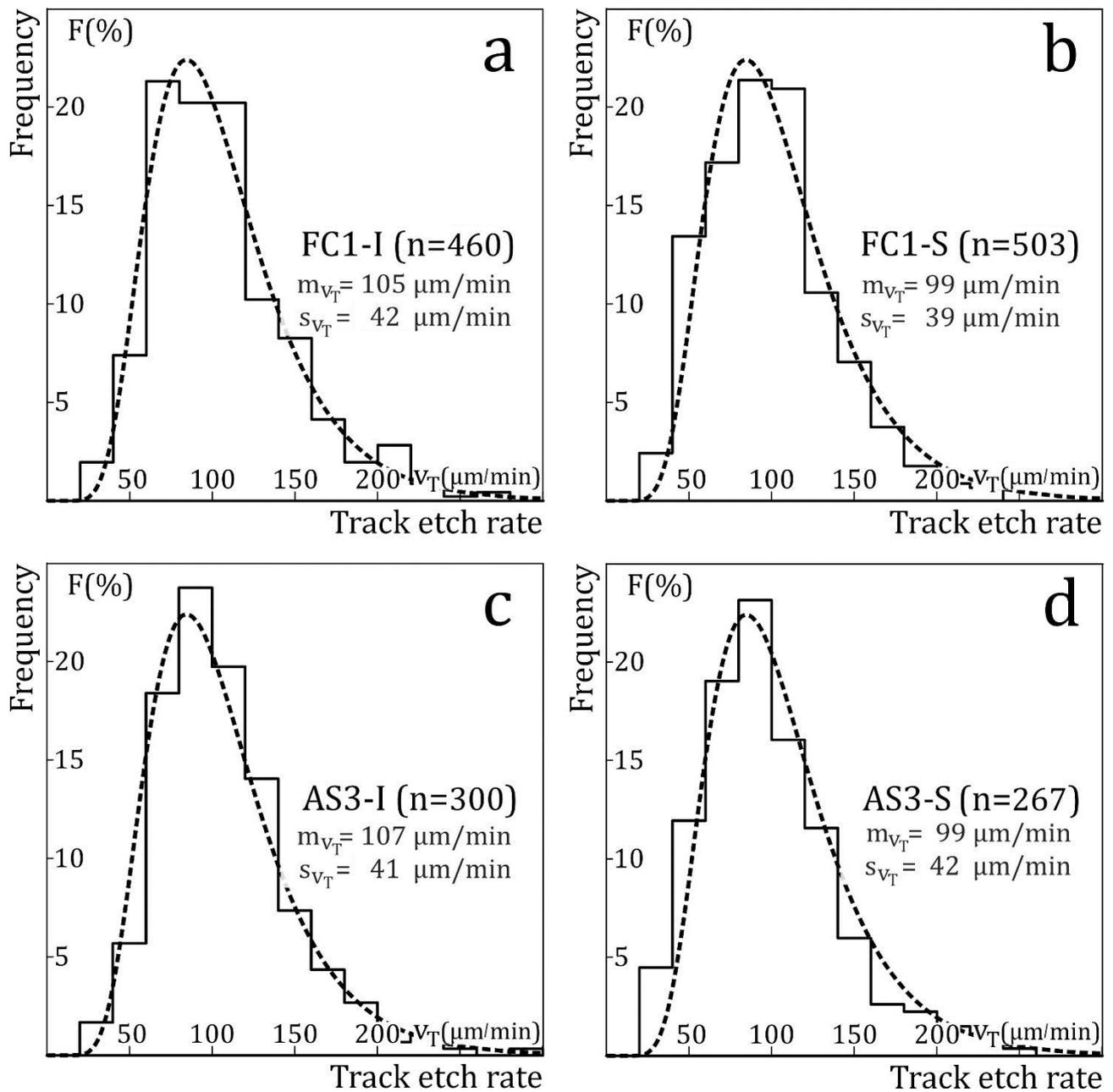


Figure S13. Distribution of the etch rates of induced and fossil confined tracks in apatite samples from the Duluth complex; **(a)**: FC-1 induced; **(b)**: FC-1 fossil; **(c)**: AS-3 induced; **(d)** AS-3 fossil. The dashed line is a polynomial fit to the combined data for the four samples; m_{v_T} : mean track etch rate; s_{v_T} : standard deviation.

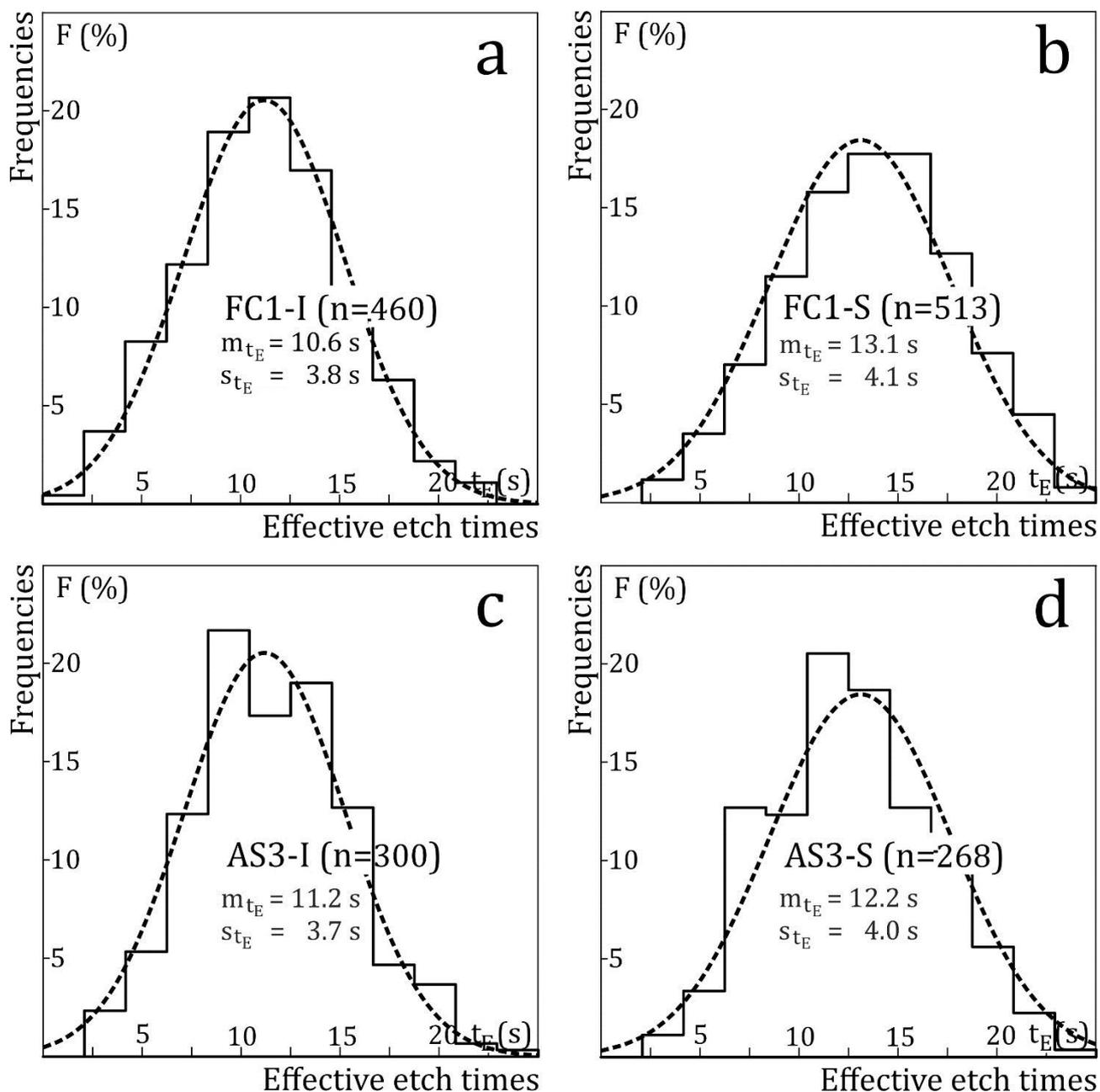


Figure S14. Effective-etch time-distributions of induced and fossil confined tracks in apatite samples from the Duluth complex; (a): FC-1 induced; (b): FC-1 fossil; (c): AS-3 induced; (d) AS-3 fossil. The dashed line is a polynomial fit to the combined data for the four samples; m_{t_E} and s_{t_E} : mean and standard deviation.

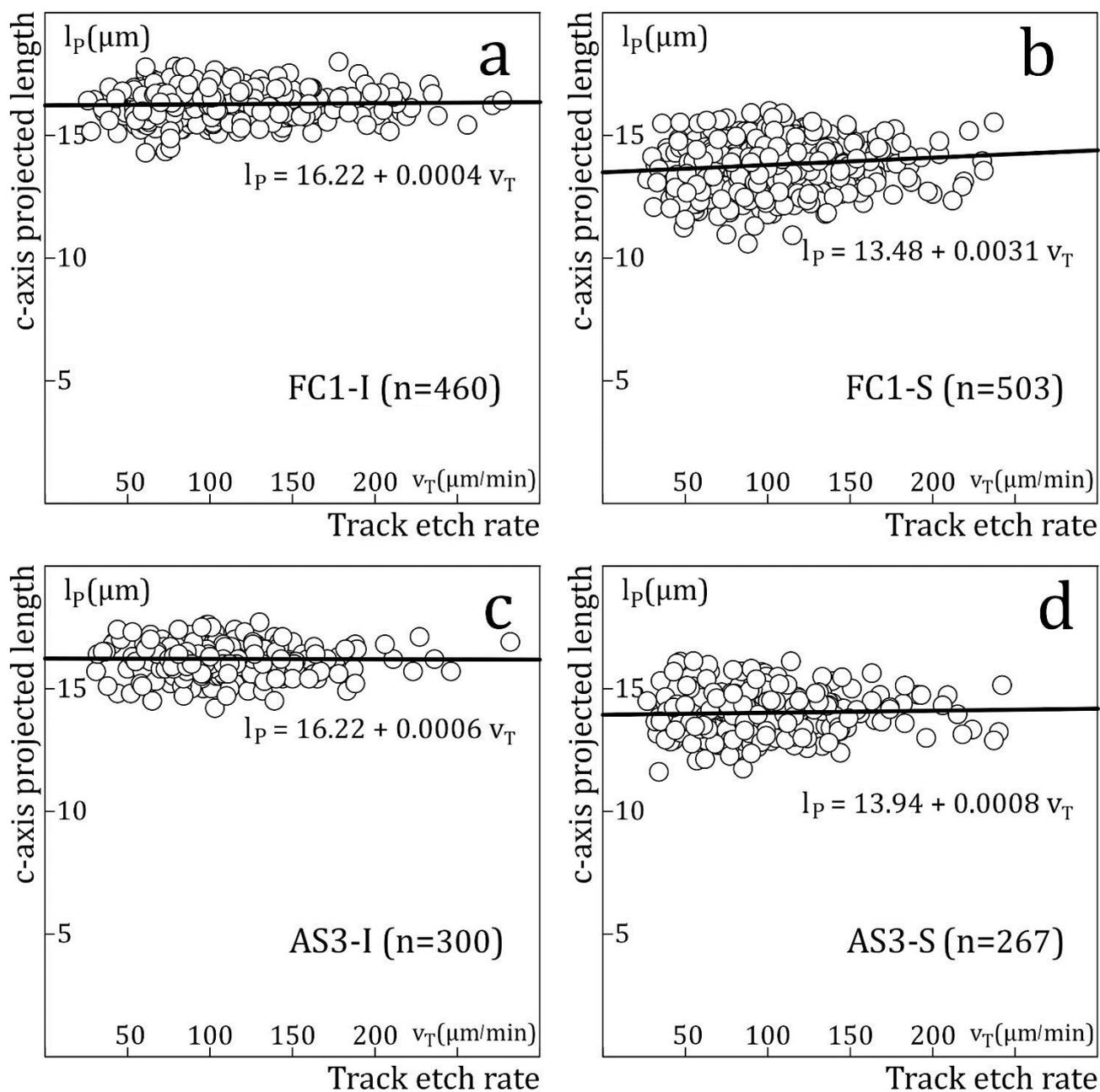


Figure S15. c-axis-projected lengths of induced and fossil confined tracks in apatite samples from the Duluth complex plotted against their track etch rates; (a): FC-1 induced; (b): FC-1 fossil; (c): AS-3 induced; (d) AS-3 fossil. The solid lines are regression lines.

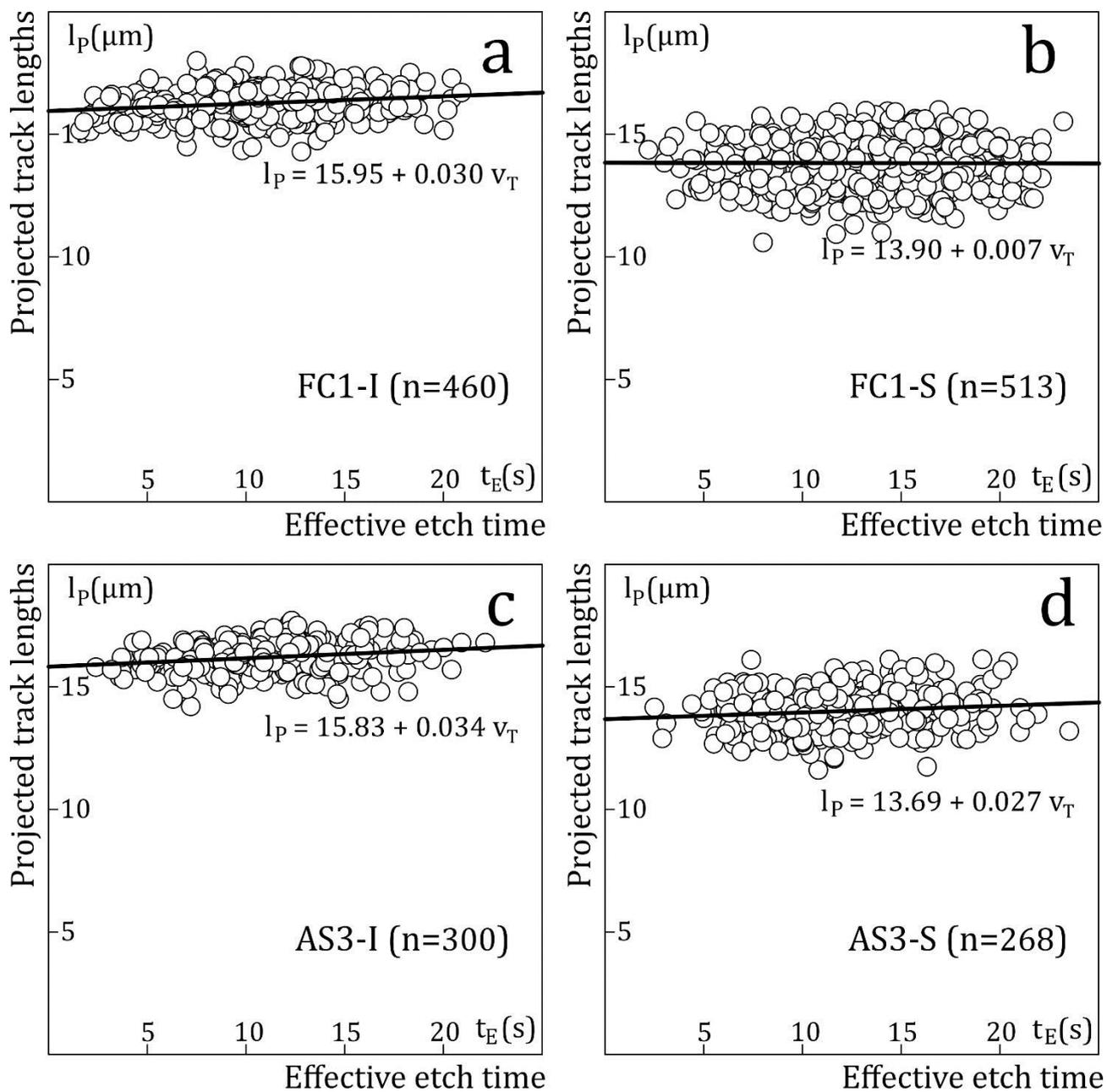


Figure S16. *c*-axis-projected lengths of induced and fossil confined tracks in apatite samples from the Duluth complex plotted against their effective etch times; (a): FC-1 induced; (b): FC-1 fossil; (c): AS-3 induced; (d) AS-3 fossil. The solid lines are regression lines.